# **Hypothesis Testing\***

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- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis
- 2. finding and evaluating tests
- 2.1 likelihood ratio test
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

## 1. basic notions in hypothesis testing

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## 1. basic notions in hypothesis testing

#### 1.1 statistical hypothesis

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## some definitions: null and alternative hypothesis

- definition: a statistical hypothesis is a statement about population parameters
- the goal is to decide which of two complementary hypotheses is true:

null hypothesis  $\mathbb{H}_0$  vs alternative hypothesis  $\mathbb{H}_1$ 

- if  $\theta$  denotes a population parameter, then the general format of the null and alternative hypotheses is  $\mathbb{H}_0: \theta \in \Theta_0$  and  $\mathbb{H}_1: \theta \in \Theta_1$
- examples:
  - if  $\theta$  represents the effect of a training program, we might be interested in  $\mathbb{H}_0: \theta=0$  against  $\mathbb{H}_1: \theta\neq 0$
  - if  $\sigma^2$  is the variance, we might be interested in understanding if volatility is too high defining  $\mathbb{H}_0: \sigma^2 = \sigma_0^2$  against  $\mathbb{H}_1: \sigma^2 > \sigma_0^2$

### some definitions: rejection region

- definition: a hypothesis test is a rule that determines for which sample values the decision is to reject or not  $\mathbb{H}_0$ 
  - we define a partition in the sample space  ${\mathcal X}$  with two sets: R and  $R^c$
  - if x ∈ R, we elect to reject H<sub>0</sub>; if x ∈ R<sup>c</sup>, we elect to not reject H<sub>0</sub>
  - -R is the rejection region and  $R^c$  is the acceptance region
  - typically, a hypothesis test is specified in terms of a test statistic T(x), but this is not necessary
  - R (and, consequently,  $R^c$ ) can be defined arbitrarily but makes little sense to do so if we want a test with good properties

#### some definitions: power function

ullet definition: the power function of a hypothesis test with a given rejection region R is the function of ullet

$$\beta(\boldsymbol{\theta}) = \mathbb{P}_{\boldsymbol{\theta}}(\boldsymbol{X} \in R)$$

- be careful: the power function ≠ power of the test!
- the terminology is misleading: one should think the power function as the probability of rejecting the null as a function of  $\theta$ , regardless of whether the null is true or not

# some definitions: type-I and type-II errors

- there are two types of error a hypothesis test  $\mathbb{H}_0$ :  $\theta \in \Theta_0$  vs  $\mathbb{H}_1$ :  $\theta \in \Theta_1$  might make
  - rejecting the null when it is true (false positive): type I error occurs if  $\theta \in \Theta_0$  and  $x \in R$
  - not rejecting the null when it is false (false negative): type II occurs if  $\theta$  ∈  $\Theta$ 1 and  $x \notin R$

		decision	
		not reject $\mathbb{H}_0$	reject $\mathbb{H}_0$
		$x \notin R$	$x \in R$
truth	$\mathbb{H}_0:oldsymbol{ heta}\in\Theta_0$	correct	type I
	$\mathbb{H}_{1}:oldsymbol{ heta}\in\Theta_{1}$	type II	correct

#### size and power function

• for each  $\theta \in \Theta_0$ ,  $\beta(\theta) = \mathbb{P}_{\theta}(X \in R)$  represents the probability that the null hypothesis is rejected while being true.

if 
$$\theta \in \Theta_0$$
:  $\beta(\theta) = \mathbb{P}_{\theta}(X \in R) = \mathbb{P}_{\theta}(\text{type I error}) = \text{size at } \theta$ 

- size varies with  $\theta$ : we need an aggregate measure for the entire test over the set  $\Theta_0$
- example: suppose  $X_i \sim N(\mu, 1)$  i.i.d. and that we test  $\mathbb{H}_0: \mu > 0$  against  $\mathbb{H}_1: \mu \leq 0$ . We elect to make  $R = \{\bar{x}_n \leq 0\}$ . The probability of  $\bar{x}_n$  being in the rejection region is completely different if  $\mu = 0.0001$  or  $\mu = 1000$ .
- definition: for  $0 \le \alpha \le 1$ , a test with power function  $\beta(\theta)$  has size  $\alpha$  if

$$\sup_{\boldsymbol{\theta}\in\Theta_{\mathbf{0}}}\beta(\boldsymbol{\theta})=\alpha$$

whereas it has level  $\alpha$  if  $\sup_{\theta \in \Theta_0} \beta(\theta) \leq \alpha$ .

• ideally, we would have size 0, which is equivalent to  $\beta(\theta) = 0$  for all  $\theta \in \Theta_0$ , but life is never this perfect

### power and power function

• for each  $\theta \in \Theta_1$ ,  $\beta(\theta) = \mathbb{P}_{\theta}(X \in R)$  represents the probability that the null hypothesis is rejected while being false.

if 
$$\theta \in \Theta_1$$
:  $\beta(\theta) = \mathbb{P}_{\theta}(X \in R) = 1 - \mathbb{P}_{\theta}(\mathsf{type} \; \mathsf{II} \; \mathsf{error}) = \mathsf{power} \; \mathsf{at} \; \theta$ 

ullet as with size, power varies with  $oldsymbol{ heta}$ , but we choose not to define an aggregate measure over  $oldsymbol{ heta} \in \Theta_1$ 

# power function for binomial probability

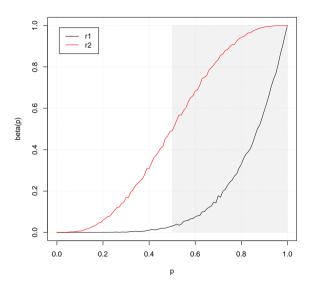
- example 1: let  $X \sim \text{Bin}(5, p)$  and consider testing  $\mathbb{H}_0 : \Theta_0 = \{p : 0 \le p \le 1/2\}$  vs  $\mathbb{H}_1 : \Theta_1 = \{p : 1/2$
- test 1:  $x \in R$  if and only if every observation is a success

$$-\beta_1(p)=\mathbb{P}_p(X=5)=p^5$$

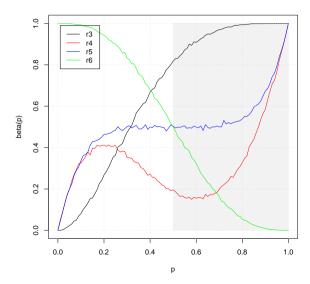
- probability of type I error is pretty low for any  $p \le 1/2$  ( $\frac{1}{2^5} = 0.0312$ )
- probability of type II error is less than half only if  $p > 0.5^{1/5} = 0.87$
- test  $2 \times R$  if and only if  $X \in \{3,4,5\}$ 
  - $\beta_2(p) = \mathbb{P}_p(X \in \{3,4,5\}) = \sum_{x=3}^5 {5 \choose x} p^x (1-p)^{5-x}$
  - $-\,$  the price we pay for a much smaller probability of type II error is a larger probability of type I error

```
 \begin{tabular}{ll} test 2 & : & x \in R \ if and only if $X \in \{3,4,5\}$ \\ \\ r1 & <- \ function(p) \{mean(rbinom(5000,5,p)==5)\} \\ \\ r2 & <- \ function(p) \{mean(rbinom(5000,5,p)>=3)\} \\ \\ p & <- \ seq(0,1,by=0.01) \\ \\ plot(p,sapply(p,r1),type='1',ylab='beta(p)',xlab='p') \\ \\ lines(p,sapply(p,r2),type='1',col='red') \\ \end{tabular}
```

test 1 :  $x \in R$  if and only if every observation is a success



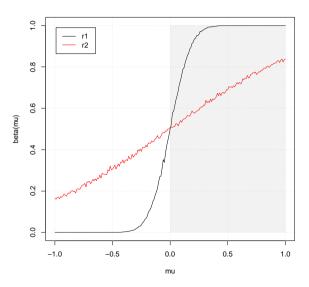
```
test 3 : rejects \mathbb{H}_0 if and only if X \in \{2, 3, 4, 5\}
                         test 4 : rejects \mathbb{H}_0 if and only if X \in \{1,5\}
                         test 5 : rejects \mathbb{H}_0 if and only if X \in \{1, 3, 5\}
                         test 6 : rejects \mathbb{H}_0 if and only if X \in \{1, 2\}
r3 <- function(p){mean(rbinom(5000,5,p)>=2)}
r4 <- function(p){
  v < - rbinom(5000,5,p)
  mean((v==1)+(v==5))
}
r5 <- function(p){
  v < - rbinom(5000.5.p)
  mean((v==1)+(v==3)+(v==5))
}
r6 <- function(p){mean(rbinom(5000,5,p)<=2)}
```



• example 2: let  $X_1, \ldots, X_n \sim$  iid  $N(\mu, 1)$  and consider testing  $\mathbb{H}_0 : \mu \leq 0$  versus  $\mathbb{H}_0 : \mu > 0$ . For that test, we propose two rejection regions

```
test 1 : x \in R if and only if \bar{X}_n > 0
test 2 : x \in R if and only if X_1 > 0
```

```
n < -50
rGaussian1 <- function(mu){
  vecTest <- matrix(0,5000,1)</pre>
  for (i in 1:5000) {vecTest[i,1] \leftarrow mean(rnorm(n,mean=mu,sd=1)) > 0}
  mean(vecTest)
rGaussian2 <- function(mu){
  vecTest <- matrix(0,5000,1)</pre>
  for (i in 1:5000) \{vecTest[i,1] < -(rnorm(1,mean=mu.sd=1)) > 0\}
  mean(vecTest)
```



- example 2 (cont'd): rejection/acceptance region R are generally arbitrary; but it is unlikely that tests with good properties would ensue
- let  $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$  and consider testing  $\mathbb{H}_0 : \mu \leq 100$  versus  $\mathbb{H}_0 : \mu > 100$ . For that test, keep the two previous tests

test 1 : 
$$x \in R$$
 if and only if  $\bar{X}_n > 0$   
test 2 :  $x \in R$  if and only if  $X_1 > 0$ 

this test will have massive size distortions, and power very close to 1.

• in the next example, we conveniently standardize the test statistic.

- example 3: let  $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$  and consider testing  $\mathbb{H}_0$ :  $\mu \leq \mu_0$  versus  $\mathbb{H}_1$ :  $\mu > \mu_0$  using a rejection region  $\bar{X}_n > \kappa$ .
- we now aim to choose  $\kappa$  such that we know the probability type-I errors, i.e., we aim to devise a test with a defined size
  - in other words,  $\alpha$  and n are fixed and we let power roam free
- we know that

$$\beta(\mu) = \mathbb{P}_{\mu} \left( \bar{X}_n > \kappa \right)$$

but we can't calculate this probability because  $\mu$  is not known, so we instead compute

$$\beta(\mu) = \mathbb{P}_{\mu}\left(\frac{\bar{X}_n - \mu}{1/\sqrt{n}} > \frac{\kappa - \mu}{1/\sqrt{n}}\right) = \mathbb{P}\left(Z > \frac{\kappa - \mu}{1/\sqrt{n}}\right)$$

with  $Z \sim N(0,1)$ .

• important to notice: we've manipulated  $\beta(\mu)$  so that it depends on some known distribution (and not on  $\mu$ ). In this way, we may forgo the simulations

• we may choose  $\kappa$  to match a test size from

$$eta(\mu) = \mathbb{P}\left(Z > \frac{\kappa - \mu}{1/\sqrt{n}}\right)$$

- since  $\beta(\mu)$  is increasing with  $\mu$ , maximum  $\beta(\mu) = \mathbb{P}\left(Z > \frac{\kappa \mu}{1/\sqrt{n}}\right)$  subject to  $\mathbb{H}_0 : \mu \leq \mu_0$  is achieved at  $\mu = \mu_0$
- so we select  $\kappa$  such that

$$\mathbb{P}\left(Z > \frac{\kappa - \mu_0}{1/\sqrt{n}}\right) = \alpha$$

• from the standard normal tables, there is value  $z_{\alpha}$  such that  $\mathbb{P}(Z > z_{\alpha}) = \alpha$ . For example, if  $\alpha = 0.05$ ,  $z_{\alpha} \approx 1.64$ . Therefore,

$$\frac{\kappa - \mu_0}{1/\sqrt{n}} = z_\alpha \implies \kappa = \mu_0 + \frac{z_\alpha}{\sqrt{n}}$$

• the rejection region

$$R = \left\{ X : \bar{X}_n > \mu_0 + \frac{z_\alpha}{\sqrt{n}} \right\}$$

was defined such that the statistical test has size  $\boldsymbol{\alpha}$ 

• this is not necessarily the most convenient formulation: consider testing  $\mathbb{H}_0$ :  $\mu \leq \mu_0$  versus  $\mathbb{H}_1$ :  $\mu > \mu_0$  using a rejection region  $\frac{\bar{X}_0 - \mu_0}{1/\sqrt{n}} > c$ 

$$\begin{split} \beta(\mu) &= \mathbb{P}_{\mu}\left(\frac{\bar{X}_{n} - \mu_{0}}{1/\sqrt{n}} > c\right) &= \mathbb{P}_{\mu}\left(\frac{\bar{X}_{n} - \mu + \mu - \mu_{0}}{1/\sqrt{n}} > c\right) \\ &= \mathbb{P}_{\mu}\left(\frac{\bar{X}_{n} - \mu}{1/\sqrt{n}} + \frac{\mu - \mu_{0}}{1/\sqrt{n}} > c\right) &= \mathbb{P}_{\mu}\left(\frac{\bar{X}_{n} - \mu}{1/\sqrt{n}} > c - \frac{\mu - \mu_{0}}{1/\sqrt{n}}\right) \\ &= \mathbb{P}\left(Z > c + \frac{\mu_{0} - \mu}{1/\sqrt{n}}\right) \text{ with } Z \sim \textit{N}(0, 1) \end{split}$$

#### • important:

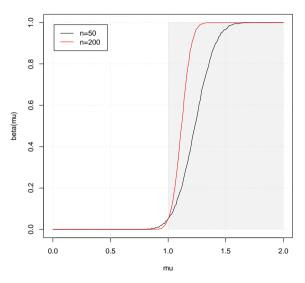
- $-\beta(\mu)$  is increasing in  $\mu$ , with  $\lim_{\mu\to-\infty}\beta(\mu)=0$ ,  $\lim_{\mu\to\infty}\beta(\mu)=1$
- if  $\mathbb{P}(Z>c)=\alpha$ , then  $\beta(\mu_0)=\alpha$ , the size of the test
- to control for size  $\alpha$ , we choose  $c = z_{\alpha}$
- power depends on the distance  $\mu_0 \mu$
- power increases to 1 as  $n \to \infty$

• that is, we have defined the rejection region

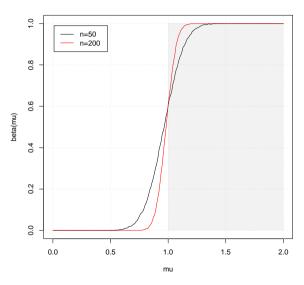
$$R = \left\{ X : \frac{\bar{X}_n - \mu_0}{1/\sqrt{n}} > z_\alpha \right\} = \left\{ X : \bar{X}_n > \mu_0 + \frac{z_\alpha}{\sqrt{n}} \right\}$$

as we had before.

c = 1.64485,  $\alpha = 0.05$ 



c = -0.25334,  $\alpha = 0.60$ 



- example 4: suppose now that the probability of type I error must not exceed 0.10 and that of type II error must not exceed 0.20 if  $\mu \geq \mu_0 + 1$
- we now aim to choose n such that we know the probability type-I and type-II errors for a given
  effect size
  - typical application: determination of sample sizes in RCTs.
- using a test that rejects  $\mathbb{H}_0$ :  $\mu \leq \mu_0$  if  $\sqrt{n}(\bar{X}_n \mu_0) > c$

$$\beta(\mu) = \mathbb{P}\left(Z > c + \frac{\mu_0 - \mu}{1/\sqrt{n}}\right) = \begin{cases} \mathbb{P}(Z > c) = 0.1 & \text{if } \mu = \mu_0 \\ \mathbb{P}(Z > c - \sqrt{n}) = 0.8 & \text{if } \mu = \mu_0 + 1 \end{cases}$$

- from  $\mathbb{P}(Z>c)=0.1$ , we get that  $c\approx 1.28$
- from  $\mathbb{P}(Z > c \sqrt{n}) = 0.8$ , we get that

$$c-\sqrt{n} \approx -0.84 \Rightarrow n \approx (c+0.84)^2 \approx 4.49$$

or  $n \geq 5$ 

• example 5: let  $X_1, \ldots, X_n$  be a random sample from  $N(\theta, \sigma^2)$ ,  $\sigma^2$  known. A test for  $\mathbb{H}_0 : \theta = \theta_0$  against  $\mathbb{H}_1 : \theta \neq \theta_0$  rejects  $\mathbb{H}_0$  if  $|\bar{X}_n - \theta_0|/(\sigma/\sqrt{n}) > c$ .

the experimenter desires a type-I error of probability 0.05 and a maximum type-II error of 0.25 at  $\theta = \theta_0 + \sigma$ . What values of n and c achieves this?

• we should first find the power function

$$\begin{split} \beta(\theta) &= \mathbb{P}_{\theta} \left( \frac{|\bar{x}_{n} - \theta_{0}|}{\sigma/\sqrt{n}} > c \right) &= 1 - \mathbb{P}_{\theta} \left( \frac{|\bar{x}_{n} - \theta_{0}|}{\sigma/\sqrt{n}} \le c \right) \\ &= 1 - \mathbb{P}_{\theta} \left( -c \le \frac{\bar{x}_{n} - \theta + \theta - \theta_{0}}{\sigma/\sqrt{n}} \le c \right) \\ &= 1 - \mathbb{P}_{\theta} \left( -c - \frac{\theta - \theta_{0}}{\sigma/\sqrt{n}} \le \frac{\bar{x}_{n} - \theta}{\sigma/\sqrt{n}} \le c - \frac{\theta - \theta_{0}}{\sigma/\sqrt{n}} \right) \\ &= 1 - \mathbb{P}_{\theta} \left( -c + \frac{\theta_{0} - \theta}{\sigma/\sqrt{n}} \le Z \le c + \frac{\theta_{0} - \theta}{\sigma/\sqrt{n}} \right) \\ &= 1 - \left[ \Phi \left( c + \frac{\theta_{0} - \theta}{\sigma/\sqrt{n}} \right) - \Phi \left( -c + \frac{\theta_{0} - \theta}{\sigma/\sqrt{n}} \right) \right] \end{split}$$

by hypothesis,

$$0.05 = \beta(\theta_0) = 1 - [\Phi(c) - \Phi(-c)]$$

$$= 1 - [\Phi(c) - 1 + \Phi(c)] = 2 - 2 \cdot \Phi(c)$$

$$0.025 = 1 - \Phi(c)$$

and c = 1.96.

• power at  $\theta = \theta_0 + \sigma$  is

.75 
$$\leq \beta(\theta_0 + \sigma) = 1 - \left[\Phi\left(c + \frac{-\sigma}{\sigma/\sqrt{n}}\right) - \Phi\left(-c + \frac{-\sigma}{\sigma/\sqrt{n}}\right)\right]$$
  
 $= 1 + \Phi(-c - \sqrt{n}) - \Phi(c - \sqrt{n})$   
 $= 1 + \Phi(-1.96 - \sqrt{n}) - \Phi(1.96 - \sqrt{n})$   
 $\approx 1 - \Phi(1.96 - \sqrt{n})$ 

since  $\Phi(-.675) \approx 0.25$ , then  $1.96 - \sqrt{n} = -.675$ , and so  $n = 6.943 \approx 7$ .

• example 6: let  $X_1, \ldots, X_n$  be a random sample from  $N(\theta, \sigma^2)$ ,  $\sigma^2$  unknown. A test for  $\mathbb{H}_0: \theta = \theta_0$  against  $\mathbb{H}_1: \theta \neq \theta_0$  rejects  $\mathbb{H}_0$  if  $|\bar{X}_n - \theta_0|/(s/\sqrt{n}) > c$ , where  $s = \sqrt{s^2} = \sqrt{\frac{1}{n-1} \sum_{i=1}^n (X_i - \bar{X}_n)^2}$ .

the experimenter desires a type-I error of probability 0.05 and a maximum type-II error of 0.25 at  $\theta = \theta_0 + \sigma$ . What values of n and c achieves this?

• we should adjust the power function

$$\beta(\theta) = \mathbb{P}_{\theta} \left( \frac{|\bar{x}_{n} - \theta_{0}|}{s/\sqrt{n}} > c \right) = 1 - \mathbb{P}_{\theta} \left( \frac{|\bar{x}_{n} - \theta_{0}|}{s/\sqrt{n}} \le c \right)$$

$$= 1 - \mathbb{P}_{\theta} \left( -c \le \frac{\bar{x}_{n} - \theta + \theta - \theta_{0}}{s/\sqrt{n}} \le c \right)$$

$$= 1 - \mathbb{P}_{\theta} \left( -c - \frac{\theta - \theta_{0}}{s/\sqrt{n}} \le \frac{\bar{x}_{n} - \theta}{s/\sqrt{n}} \le c - \frac{\theta - \theta_{0}}{\sigma/\sqrt{n}} \right)$$

$$= 1 - \mathbb{P}_{\theta} \left( -c + \frac{\theta_{0} - \theta}{s/\sqrt{n}} \le t \le c + \frac{\theta_{0} - \theta}{s/\sqrt{n}} \right)$$

$$= 1 - \left[ F \left( c + \frac{\theta_{0} - \theta}{s/\sqrt{n}} \right) - F \left( -c + \frac{\theta_{0} - \theta}{s/\sqrt{n}} \right) \right]$$

where  $t \sim t_{n-1}$  with cdf  $F(\cdot)$ .

#### power function for Bernoulli with CLT

- example 7: for a random sample  $X_1, \ldots, X_n$  of Bernoulli(p) variables, it is desired to test  $\mathbb{H}_0: p=0.49$  against  $\mathbb{H}_1: p=0.51$ . Use the central limit theorem to determine, approximately, the sample size needed so that the two probabilities of error are both about 0.01. Use a test function that rejects  $\mathbb{H}_0$  if  $\sum_{i=1}^n X_i$  is large.
- solution: by the CLT,

$$Z = \frac{\sum X_i - np}{\sqrt{np(1-p)}} \stackrel{d}{\longrightarrow} N(0,1)$$

a test that rejects  $\mathbb{H}_0$  if  $\sum X_i > c$  has

$$\mathbb{P}\left(Z > \frac{c - n(.49)}{\sqrt{n(.49)(.51)}}\right) = 0.01 \text{ and } \mathbb{P}\left(Z > \frac{c - n(.51)}{\sqrt{n(.49)(.51)}}\right) = 0.01$$

therefore

$$\frac{c - n(.49)}{\sqrt{n(.49)(.51)}} = 2.33$$
 and  $\frac{c - n(.51)}{\sqrt{n(.49)(.51)}} = -2.33$ 

solving these equations gives n = 13.567 and c = 6783.5.

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### previous examples

• in most previous examples, we've used rejection regions of the format

$$R = \left\{ X : T(X) > \kappa \right\}$$

which is an interval  $(\kappa, \infty)$  for a sufficient statistic T(X).

- example 2:  $R = \left\{ X : \bar{X}_n > 0 \right\}$
- example 3:  $R = \left\{X : \bar{X}_n > \frac{z_\alpha}{\sqrt{n} + \mu_0}\right\}$
- example 4:  $R = \left\{ X : \sqrt{n}(\bar{X}_n \mu_0) > c \right\}$
- example 5:  $R = \left\{ X : |\bar{X}_n \theta_0|/(\sigma/\sqrt{n}) > c \right\}$
- example 6:  $R = \{X : \sum X_i \text{ "large" }\}$
- we are going to see that rejection regions of this format are well-grounded by theory

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#### likelihood ratio test

- it is a very general method of finding acceptance/rejection regions, virtually always applicable and optimal in some sense that we will discuss later
- definition: the LR test for  $\mathbb{H}_0$ :  $\theta \in \Theta_0$  against  $\mathbb{H}_1$ :  $\theta \in \Theta_1$  is a test with a rejection region of the form  $R = \{x : \lambda(x) \leq c\}$ , where  $0 \leq c \leq 1$  and

$$\lambda(x) = \frac{\sup_{\theta \in \Theta_0} \ell(\theta|x)}{\sup_{\theta \in \Theta} \ell(\theta|x)} = \frac{\ell(\hat{\theta}_0|x)}{\ell(\hat{\theta}|x)}$$

- if the restriction is not binding, the constrained maximization  $\ell(\hat{\theta}_0|x)$  will be the same as the unconstrained maximization  $\ell(\hat{\theta}|x)$  and  $\lambda(x)=1$
- for now, think c as a fixed constant. We will soon see what that choice entails!

#### LR test for the Gaussian mean

• example 1: let  $(X_1, \ldots, X_n)$  be a random sample from a  $N(\mu, 1)$  population and consider testing  $\mathbb{H}_0$ :  $\mu = \mu_0$  versus  $\mathbb{H}_1$ :  $\mu \neq \mu_0$ , then

$$\lambda(\mathbf{x}) = \frac{\ell(\mu_0|\mathbf{x})}{\ell(\bar{x}_n|\mathbf{x})} = \frac{(2\pi)^{-n/2} \exp\left[-\sum_{i=1}^n (x_i - \mu_0)^2/2\right]}{(2\pi)^{-n/2} \exp\left[-\sum_{i=1}^n (x_i - \bar{x}_n)^2/2\right]}$$

$$= \exp\left[-\frac{\sum_{i=1}^n (x_i - \mu_0)^2 - \sum_{i=1}^n (x_i - \bar{x}_n)^2}{2}\right]$$

$$= \exp\left[-\frac{n(\bar{x}_n - \mu_0)^2}{2}\right],$$

and for  $\lambda(x) = c$ ,

$$\ln c = -\frac{n(\bar{x}_n - \mu_0)^2}{2} \Rightarrow (\bar{x}_n - \mu_0)^2 = -2(\ln c)/n$$

yielding a rejection region

$$\{x: \lambda(x) \leq c\} = \left\{x: |\bar{x}_n - \mu_0| \geq \sqrt{-2(\ln c)/n}\right\}$$

#### size of a LR test

- in general, to derive a size  $\alpha$  LR test that rejects the null  $\mathbb{H}_0$ :  $\theta \in \Theta_0$  if  $\lambda(x) \leq c$ , we choose c such that  $\sup_{\theta \in \Theta_0} \mathbb{P}_{\theta}(\lambda(x) \leq c) = \alpha$
- example 1 (cont'd): let  $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$  and consider testing  $\mathbb{H}_0$ :  $\mu = \mu_0$  using a LR test that rejects if  $|\bar{x}_n \mu_0| \geq \sqrt{-2(\ln c)/n}$ . Then

$$\mathbb{P}\left(|\bar{x}_n - \mu_0| \ge \sqrt{-2(\ln c)/n}\right) = \mathbb{P}\left(\frac{|\bar{x}_n - \mu_0|}{1/\sqrt{n}} \ge \sqrt{-2(\ln c)}\right) = \alpha$$

and since  $\frac{\bar{s}_n - \mu_0}{1/\sqrt{n}} \sim N(0,1)$  we can choose c such that  $\sqrt{-2(\ln c)}$  yields the probability above being equal to  $\alpha$ . This will be obtained at  $\sqrt{-2(\ln c)} = z_{\alpha/2}$ , which implies

$$c = \exp(-z_{\alpha/2}^2/2)$$

# LR test for the exponential distribution

• example 2: let  $(X_1, \ldots, X_n)$  be a random sample from an exponential population with pdf

$$f(x_i|\theta) = \begin{cases} e^{-(x_i-\theta)} & x_i \geq \theta \\ 0 & x_i < \theta \end{cases}$$

so the likelihood function is

$$f(\mathbf{x}|\theta) = \begin{cases} e^{-(\sum x_i - n\theta)} & x_{(1)} \ge \theta \\ 0 & x_{(1)} < \theta \end{cases}$$

and consider testing  $\mathbb{H}_0$ :  $\theta \leq \theta_0$  versus  $\mathbb{H}_1$ :  $\theta > \theta_0$ 

• if  $x_{(1)} \ge \theta$ ,  $\ell(\theta|\mathbf{x}) = \prod_{i=1}^n f(x_i|\theta)$  is an increasing function of  $\theta$ . Then unrestricted maximum is obtained at  $\hat{\theta} = x_{(1)}$  with maximum

$$\ell(\hat{\theta}|\mathbf{x}) = \ell(\mathbf{x}_{(1)}|\mathbf{x}) = e^{-(\sum x_i - n\mathbf{x}_{(1)})}$$

# LR test for the exponential distribution

- now for the restricted maximum  $\ell(\hat{\theta}_0|x)$ 
  - if  $x_{(1)} \leq \theta_0$ , then restriction is not binding and  $\ell(\hat{\theta}_0|\mathbf{x}) = \ell(\hat{\theta}|\mathbf{x})$
  - if  $x_{(1)} > \theta_0$ , then  $\hat{\theta}_0 = \theta_0$  and  $\ell(\theta_0|\mathbf{x}) = e^{-(\sum x_i n\theta_0)}$
- the likelihood test statistic is

$$\lambda(\mathbf{x}) = \begin{cases} 1 & x_{(1)} \leq \theta_0 \\ e^{-n(x_{(1)} - \theta_0)} & x_{(1)} > \theta_0 \end{cases}$$

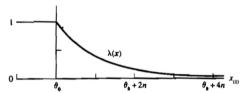


Figure 8.2.1.  $\lambda(\mathbf{x})$ , a function only of  $x_{(1)}$ .

# LR test for the exponential distribution

• therefore, a test that rejects  $\mathbb{H}_0$  if  $\lambda(X) \leq c$  is such that

$$e^{-n(x_{(1)}-\theta_0)} \le c \Rightarrow -n(x_{(1)}-\theta_0) \le \ln c \Rightarrow x_{(1)} \ge \theta_0 - \frac{\ln c}{n}$$
  
rejection region  $\{x: \lambda(x) \le c\} = \{x: x_{(1)} \ge \theta_0 - (\ln c)/n\}$ 

• now find c that matches a desired size  $\alpha$ . General fact:

$$\mathbb{P}(X_i \leq k) = \int_{\theta_0}^k e^{-(x-\theta_0)} dx = \left[ -e^{-(x-\theta_0)} \right]_{\theta_0}^k = 1 - e^{-(x-\theta_0)}$$

therefore the probability that all  $X_1, \ldots, X_n$  are greater than k is

$$\mathbb{P}\left(X_{(1)} \geq k\right) = e^{-n(k-\theta_{\mathbf{0}})}$$

• in the test,  $k = \theta_0 - (\ln c)/n$ , so we must choose c such that

$$e^{-n(\theta_0 - (\ln c)/n - \theta_0)} = \alpha$$

which just implies that  $c = \alpha$ .

### sufficient statistics are sufficient for LR tests

- is it a coincidence that likelihood ratio tests on the normal and exponential depended on sufficient statistics (respectively,  $\bar{x}_n$  and  $x_{(1)}$ )?
- if T(X) is a sufficient statistic for  $\theta$  with pdf/pmf  $g(t|\theta)$ , then LR tests based on T and its likelihood function  $\ell_*(\theta|t) = g(t|\theta)$  should be as good as LR tests based on  $\ell(\theta|x)$
- theorem (equivalence):  $\lambda_*(T(x)) = \lambda(x)$  for every x in the sample space if T(X) is a sufficient statistic for  $\theta$
- proof: it follows from the factorization theorem that

$$\lambda(\mathbf{x}) = \frac{\sup_{\theta \in \Theta_{\mathbf{0}}} \ell(\theta|\mathbf{x})}{\sup_{\theta \in \Theta} \ell(\theta|\mathbf{x})} = \frac{\sup_{\theta \in \Theta_{\mathbf{0}}} g(T(\mathbf{x})|\theta)h(\mathbf{x})}{\sup_{\theta \in \Theta} g(T(\mathbf{x})|\theta)h(\mathbf{x})} = \frac{\sup_{\theta \in \Theta_{\mathbf{0}}} \ell_*(\theta|T(\mathbf{x}))}{\sup_{\theta \in \Theta} \ell_*(\theta|T(\mathbf{x}))} = \lambda_*(T(\mathbf{x}))$$

# nuisance parameters do not annoy so much

- likelihood tests are also convenient if there are nuisance parameters, that is to say, parameters for which we have no inferential interest
- they do not affect the LR test construction method, though their presence might result in a different test
- example: suppose  $X_1, \ldots, X_n \sim \text{iid } N(\mu, \sigma^2)$  and that we wish to test  $\mathbb{H}_0 : \mu \leq \mu_0$  against  $\mathbb{H}_1 : \mu > \mu_0$

$$\begin{split} \lambda(\mathbf{x}) &= \frac{\max_{\mu \leq \mu_{\mathbf{0}}, \sigma^2 \geq 0} \ell(\mu, \sigma^2 | \mathbf{x})}{\max_{\mu \in \mathbb{R}, \sigma^2 \geq 0} \ell(\mu, \sigma^2 | \mathbf{x})} \\ &= \frac{\max_{\mu \leq \mu_{\mathbf{0}}, \sigma^2 \geq 0} \ell(\mu, \sigma^2 | \mathbf{x})}{\ell(\overline{\mathbf{x}}_n, \hat{\sigma}^2 | \mathbf{x})} \\ &= \begin{cases} 1 & \text{if } \overline{\mathbf{x}}_n \leq \mu_{\mathbf{0}} \\ \frac{\ell(\mu_{\mathbf{0}}, \hat{\sigma}^2 | \mathbf{x})}{\ell(\overline{\mathbf{x}}_n, \hat{\sigma}^2 | \mathbf{x})} & \text{if } \overline{\mathbf{x}}_n > \mu_{\mathbf{0}} \end{cases} \end{split}$$

#### Contents

- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis

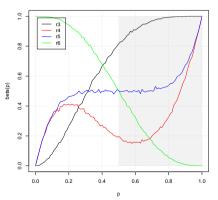
### 2. finding and evaluating tests

- 2.1 likelihood ratio tes
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

### most powerful tests

- general principle: a good test should have for a given probability of type-I error the smallest possible probability of type-II error
- definition: unbiased tests are more likely to reject  $\mathbb{H}_0$  if the null is false than if it is true, and hence their power functions are such that  $\beta(\theta_1) \geq \beta(\theta_0)$  if  $\theta_0 \in \Theta_0$  and  $\theta_1 \in \Theta_1$

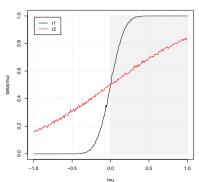
(un)biased tests here?



### most powerful tests

- definition: let  $\mathcal C$  be a class of tests for  $\mathbb H_0$ :  $\theta \in \Theta_0$  versus  $\mathbb H_1$ :  $\theta \in \Theta_1$ , then a test in  $\mathcal C$  with power function  $\beta(\theta)$  is a uniformly most powerful class  $\mathcal C$  test if  $\beta(\theta) \geq \tilde{\beta}(\theta)$  for every  $\theta \in \Theta_1$  and every  $\tilde{\beta}(\theta)$  that is a power function of a test in class  $\mathcal C$
- we typically consider the class  $\mathcal C$  of all level  $\alpha$  tests, because we have to control anyway the probability of type I error





### Neyman-Pearson lemma

• theorem (Neyman-Pearson lemma) (CB 8.3.12): consider testing  $\mathbb{H}_0$ :  $\theta = \theta_0$  versus  $\mathbb{H}_1$ :  $\theta = \theta_1$ , where the pdf/pmf corresponding to  $\theta_i$  is  $f(\mathbf{x}|\theta_i)$  for i = 0, 1 using a test with rejection region R such that

$$x \in R$$
 if  $f(x|\theta_1) > kf(x|\theta_0)$   
 $x \in R^c$  if  $f(x|\theta_1) < kf(x|\theta_0)$ 

for some k > 0, and  $\mathbb{P}_{\theta_0}(x \in R) = \alpha$ , then

- (i) (Sufficiency) such a test is a UMP level  $\alpha$  test
- (ii) (Necessity) if there exists such a test, then every UMP level  $\alpha$  test is a size  $\alpha$  test
- (iii) (Necessity) every UMP level  $\alpha$  test has a rejection region of the above form, except perhaps on a set A of null measure under  $\theta_0$  and  $\theta_1 \colon \mathbb{P}_{\theta_0}(\mathbf{X} \in A) = \mathbb{P}_{\theta_1}(\mathbf{X} \in A) = 0$
- remember: for  $0 \le \alpha \le 1$ , a test with power function  $\beta(\theta)$  has size  $\alpha$  if

$$\sup_{\boldsymbol{\theta}\in\Theta_{\mathbf{0}}}\beta(\boldsymbol{\theta})=\alpha$$

whereas it has level  $\alpha$  if  $\sup_{\theta \in \Theta_0} \beta(\theta) \leq \alpha$ 

## Neyman-Pearson lemma

- proof (i): let  $\phi(x)$  denote the test function of the Neyman-Pearson test, taking value 1 if  $x \in R$  and zero if  $x \in R^c$ , and  $\tilde{\phi}(x)$  any other level  $\alpha$  test function  $0 \le \tilde{\phi}(x) \le 1$
- the Neyman-Pearson rejection region implies that, for every sample point x,

$$\left[\phi(\mathbf{x}) - \tilde{\phi}(\mathbf{x})\right] \left[f(\mathbf{x}|\theta_1) - kf(\mathbf{x}|\theta_0)\right] \geq 0$$

and hence

$$0 \leq \int \left[\phi(\mathbf{x}) - \tilde{\phi}(\mathbf{x})\right] \left[f(\mathbf{x}|\theta_1) - kf(\mathbf{x}|\theta_0)\right] d\mathbf{x}$$

$$= \beta(\theta_1) - \tilde{\beta}(\theta_1) - k\left[\beta(\theta_0) - \tilde{\beta}(\theta_0)\right]$$

$$= \beta(\theta_1) - \tilde{\beta}(\theta_1) - k\left[\alpha - \tilde{\beta}(\theta_0)\right]$$

$$\leq \beta(\theta_1) - \tilde{\beta}(\theta_1)$$

for  $k \geq 0$  given that  $\alpha - \tilde{\beta}(\theta_0) \geq 0$ , hence  $\beta(\theta_1) \geq \tilde{\beta}(\theta_1)$ . That is, the NP test has greater power than any other test.

## Neyman-Pearson lemma

• proof (ii): let now  $\tilde{\phi}(x)$  denote any UMP level  $\alpha$  test function and note that, by sufficiency,  $\phi(x)$  is also UMP level  $\alpha$  test. Because  $\phi$  and  $\tilde{\phi}$  are both UMP tests,  $\beta(\theta_1) = \tilde{\beta}(\theta_1)$ , it then follows from

$$\beta(\theta_1) - \tilde{\beta}(\theta_1) - k[\beta(\theta_0) - \tilde{\beta}(\theta_0)] \geq 0$$

with k > 0 that  $-k \left[\beta(\theta_0) - \tilde{\beta}(\theta_0)\right] \ge 0 \Rightarrow \beta(\theta_0) - \tilde{\beta}(\theta_0) \le 0$ . Then

$$0 \leq \alpha - \tilde{\beta}(\theta_0) = \beta(\theta_0) - \tilde{\beta}(\theta_0) \leq 0$$

and hence  $\tilde{\beta}(\theta_0) = \alpha$  and  $\tilde{\phi}$  is in fact a size  $\alpha$  test.

proof (iii): this implies that

$$\underbrace{\frac{\beta(\theta_1) - \tilde{\beta}(\theta_1)}{\beta(\theta_0) - \tilde{\beta}(\theta_0)}}_{=0} - k \underbrace{\left[\beta(\theta_0) - \tilde{\beta}(\theta_0)\right]}_{=0} = \int \left[\phi(x) - \tilde{\phi}(x)\right] \left[f(x|\theta_1) - kf(x|\theta_0)\right] dx$$

which implies only if  $\tilde{\phi}$  has the same rejection region of the Neyman-Pearson test, except on a set A with  $\int_A f(\mathbf{x}|\theta_i) d\mathbf{x} = 0, \forall i = 1, 2$ .

### example

• example 1 (CB 8.20): let X be a random variable with distribution under  $\mathbb{H}_0$  and  $\mathbb{H}_1$  given by

X	1	2	3	4	5	6	7
$f(x \mathbb{H}_0)$	0.01	0.01	0.01	0.01	0.01	0.01	0.94
$f(x \mathbb{H}_1)$	0.06	0.05	0.04	0.03	0.02	0.01	0.79

use the Neyman-Pearson lemma to find the most powerful test for  $\mathbb{H}_0$  against  $\mathbb{H}_1$  with size  $\alpha=0.04$ . Compute the probability of type-II error.

solution: by the NP lemma, we should define the rejection region

$$x \in R$$
 if  $f(x|\theta_1) > kf(x|\theta_0)$ 

that is,  $\frac{f(x|\theta_1)}{f(x|\theta_0)} > k$ .

so rejecting for large values of k corresponds to small values of x. A test with size  $\alpha=0.04$  is such that  $\mathbb{P}(X \leq c | \mathbb{H}_0) = 0.04$ , which is achieved at c=4. The type-II error is  $\mathbb{P}(X \in \{5,6,7\} | \mathbb{H}_1) = .82$ .

# UMP test for the binomial probability

• example 2: let  $X \sim \text{Bin}(2,p)$  and consider testing  $\mathbb{H}_0$ : p=1/2 against  $\mathbb{H}_1$ : p=3/4 using the pmf ratios

$$\frac{f\left(0|p=\frac{3}{4}\right)}{f\left(0|p=\frac{1}{2}\right)} = \frac{\frac{1}{4}\frac{1}{4}}{\frac{1}{2}\frac{1}{2}} = \frac{1}{4} \; ; \quad \frac{f\left(1|p=\frac{3}{4}\right)}{f\left(1|p=\frac{1}{2}\right)} = \frac{2\frac{1}{4}\frac{3}{4}}{2\frac{1}{2}\frac{1}{2}} = \frac{3}{4} \; ; \quad \frac{f\left(2|p=\frac{3}{4}\right)}{f\left(2|p=\frac{1}{2}\right)} = \frac{\frac{3}{4}\frac{3}{4}}{\frac{1}{2}\frac{1}{2}} = \frac{9}{4}$$

- if we choose...
  - $-k>\frac{9}{4}$  yields the UMP with level  $\alpha=0$
  - $-\frac{3}{4} < k < \frac{9}{4}$ , the test that rejects  $\mathbb{H}_0$  if X=2 is UMP with level

$$\alpha = \mathbb{P}\left(X = 2|\theta = \frac{1}{2}\right) = \frac{1}{4}$$

 $-\frac{1}{4} < k < \frac{3}{4}$ , the test that rejects  $\mathbb{H}_0$  if  $X = \{1, 2\}$  is UMP with level

$$\alpha = \mathbb{P}\left(X = 1 \text{ or } 2|\theta = \frac{1}{2}\right) = \frac{3}{4}$$

 $-k<rac{1}{4}$  yields the UMP with level lpha=1

# how about sufficiency?

• corollary of NP lemma: suppose T(X) is sufficient for  $\theta$ , with pdf/pmf  $g(t|\theta_i)$  corresponding to  $\theta_i$  (i=0,1), then any test based on T(X) with rejection region S such that

$$t \in S$$
 if  $g(t|\theta_1) > kg(t|\theta_0)$   
 $t \in S^c$  if  $g(t|\theta_1) < kg(t|\theta_0)$ 

for some  $k \geq 0$ , where  $\mathbb{P}_{\theta_0}(T(x) \in S) = \alpha$ , is a UMP level  $\alpha$  test.

• proof: in terms of the original sample X, the test based on T(X) has rejection region  $R = \{x : T(x) \in S\}$  such that

$$x \in R$$
 if  $f(x|\theta_1) = g(T(x)|\theta_1)h(x) > kg(T(x)|\theta_0)h(x) = kf(x|\theta_0)$   
 $x \in R^c$  if  $f(x|\theta_1) = g(T(x)|\theta_1)h(x) < kg(T(x)|\theta_0)h(x) = kf(x|\theta_0)$ 

and  $\mathbb{P}_{\theta_0}(X \in R) = \mathbb{P}_{\theta_0}(T(X) \in S)$ , so it is also a UMP level  $\alpha$  test by the Neyman-Pearson lemma.

#### UMP test for the normal mean

• example 3: let  $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$  and consider testing  $\mathbb{H}_0$ :  $\mu = \mu_0$  against  $\mathbb{H}_1$ :  $\mu = \mu_1$ , with  $\mu_0 > \mu_1$ . We had that

$$f(\mathbf{x}|\mu,\sigma^2) = (2\pi\sigma^2)^{-n/2} \exp\left\{-\frac{\sum_{i=1}^n (x_i - \bar{x}_n)^2 + n(\bar{x}_n - \mu)^2}{2\sigma^2}\right\}$$

so, applying the NP lemma,

$$\frac{f(\mathbf{x}|\mu_1, 1)}{f(\mathbf{x}|\mu_0, 1)} = \exp\left\{\frac{n(\bar{\mathbf{x}}_n - \mu_0)^2 - n(\bar{\mathbf{x}}_n - \mu_1)^2}{2\sigma^2}\right\} > k$$

so that  $(\bar{x}_n - \mu_0)^2 - (\bar{x}_n - \mu_1)^2 > \frac{1}{n} 2\sigma^2 \ln k$ . We need to isolate  $\bar{x}_n$ :

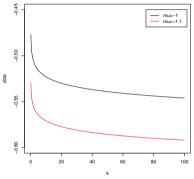
$$(\bar{x}_n - \mu_0)^2 - (\bar{x}_n - \mu_1)^2 = \bar{x}_n^2 - 2\bar{x}_n\mu_0 + \mu_0^2 - \bar{x}_n^2 + 2\bar{x}_n\mu_1 - \mu_1^2$$
  
= 
$$-2\bar{x}_n\mu_0 + \mu_0^2 + 2\bar{x}_n\mu_1 - \mu_1^2$$

and given that  $\mu_1 - \mu_0 < 0$ , the rejection region is of the format

$$\bar{x}_n < \frac{\frac{1}{n} 2\sigma^2 \ln k - \mu_0^2 + \mu_1^2}{2(\mu_1 - \mu_0)} \iff \bar{x}_n < c$$

### UMP test for the normal mean

• example 3 (cont'd): for  $\mu_0 = 0$ , n = 100 and  $\sigma^2 = 1$ , this function looks like



equivalent to say that, for any k, there is a c such that  $\bar{x}_n < c$ . This means that a test with rejection region

$$\bar{x}_n < c = \theta_0 - \frac{\sigma z_\alpha}{\sqrt{n}}$$

is the UMP level  $\alpha$  test.

## composite hypothesis

- $\mathbb{H}_0$  and  $\mathbb{H}_1$  in the Neyman-Pearson lemma are simple hypotheses in that they specify only one possible distribution for sample X, i.e.,  $\mathbb{H}_0$  and  $\mathbb{H}_1$  are singletons.
- composite hypotheses: in most realistic problems, the hypotheses of interest specify more than one possible distribution for the sample

one-sided tests: 
$$\mathbb{H}_0: \mu \leq \mu_0 \text{ vs } \mathbb{H}_1: \mu > \mu_0$$
 two-sided tests:  $\mathbb{H}_0: \mu = \mu_0 \text{ vs } \mathbb{H}_1: \mu \neq \mu_0$ 

• is the Neyman-Pearson lemma applicable? We shall defer this question to when we talk about union-intersection tests.

#### one-sided tests

- a large class of problems that admit UMP level lpha tests involve one-sided hypotheses and pdfs/pmfs with the monotone LR property
- definition: a family of pdfs/pmfs  $\{g(t|\theta): \theta \in \Theta\}$  for a univariate random variable T with parameter  $\theta \in \mathbb{R}$  has a monotone likelihood ratio if for every  $\theta_2 > \theta_1$ ,  $g(t|\theta_2)/g(t|\theta_1)$  is a monotone function of t on  $\{t: g(t|\theta_1) > 0 \text{ or } g(t|\theta_2) > 0\}$
- interestingly, any exponential family with  $g(t|\theta) = h(t)c(\theta) \exp\{w(\theta)t\}$  has an MLR if  $w(\theta)$  is nondecreasing
- theorem (Karlin-Rubin) (CB 8.3.17): consider testing  $\mathbb{H}_0$ :  $\theta \leq \theta_0$  versus  $\mathbb{H}_1$ :  $\theta > \theta_0$  using a sufficient statistic T whose pdf/pmf satisfies the MLR property, then the UMP level  $\alpha$  test rejects the null if  $T > t_0$  with  $\mathbb{P}_{\theta_0}(T > t_0) = \alpha$ .

#### one-sided tests

- example:  $X_1, \ldots, X_n$  i.i.d. standard normal. Consider testing  $\mathbb{H}'_0: \theta \geq \theta_0$  versus  $\mathbb{H}'_1: \theta < \theta_0$ .
- since  $\bar{X}_n$  is sufficient and distribution has a monotone likelihood ratio, we can apply the Karlin-Rubin theorem which states that we should reject the null if

$$\bar{x}_n < \theta_0 - \frac{\sigma z_\alpha}{\sqrt{n}}$$

and the power function is

$$\beta(\theta) = \mathbb{P}_{\theta}\left(\bar{X}_n < \theta_0 - \frac{\sigma z_{\alpha}}{\sqrt{n}}\right)$$

which is a decreasing function of  $\theta_0$ . The value  $\alpha$  is given by

$$\sup_{\theta > \theta_0} \beta(\theta) = \beta(\theta_0) = \alpha$$

- example: let  $\{X_1,\ldots,X_n\} \sim N(\mu,\sigma^2)$  i.i.d. with  $\sigma^2$  known, and consider testing  $\mathbb{H}_0: \mu \leq 0$  against  $\mathbb{H}_1: \mu > 0$ .
  - test 1: take the test statistic  $\frac{\bar{X}_n \mu_0}{\sigma/\sqrt{n}} > c$ , where  $c = z_\alpha$ , with rejection region

$$R_1 = \left\{ X : \frac{\bar{X}_n - \mu_0}{\sigma/\sqrt{n}} > z_{\alpha} \right\} = \left\{ X : \bar{X}_n > \mu_0 + \sigma \frac{z_{\alpha}}{\sqrt{n}} \right\}$$

which is the UMP test of level  $\alpha$ .

- test 2: using only the first 5 observations, also with level  $\alpha$ 

$$R_2 = \left\{ X : \frac{\bar{X}_5 - \mu_0}{\sigma / \sqrt{5}} > z_\alpha \right\} = \left\{ X : \bar{X}_5 > \mu_0 + \sigma \frac{z_\alpha}{\sqrt{5}} \right\}$$

• test 3:

$$R_3 = \left\{ X : \sum_{i=1}^n \frac{X_i^2}{\sigma^2} > \kappa \text{ if } \bar{X}_n > 0 \right\}$$

and we need to find  $\kappa$  such that the probability of rejecting is  $\alpha$ .

$$\mathbb{P}(X \in R_3) = \mathbb{P}\left\{ \sum_{i=1}^n \frac{X_i^2}{\sigma^2} > \kappa \middle| \bar{X}_n > 0 \right\} \cdot \mathbb{P}\left(\bar{X}_n > 0\right)$$

while

$$\mathbb{P}\left(\bar{X}_n < 0\right) \quad = \quad \mathbb{P}\left(\sqrt{n}\frac{\bar{X}_n - \mu}{\sigma} < -\sqrt{n}\frac{\mu}{\sigma}\right) \quad = \quad \mathbb{P}\left(Z < \sqrt{n}\frac{\mu}{\sigma}\right)$$

given that  $\sqrt{n} \frac{\bar{X}_n - \mu}{\sigma} \sim \mathcal{N}(0, 1)$ . Conditional of  $\bar{X}_n > 0$ ,  $\sum_{i=1}^n \frac{X_i}{\sigma^2} \sim \chi_n^2$  from the  $\chi_n^2$  distribution, so we can find a  $\kappa = q_{\alpha^*}$  such that  $\mathbb{P}\left(\sum_{i=1}^n \frac{X_i}{\sigma^2} < q_{\alpha^*}\right) = \alpha^*$ .

• taking  $\mu = 0$ ,

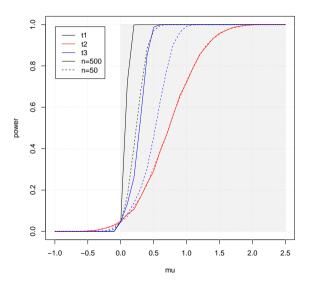
$$\mathbb{P}(X \in R_3) = 0.5(1 - \alpha^*) = \alpha \implies \alpha^* = 1 - 2\alpha$$

```
n < -500
sigma2 <- 1
alpha <- 0.05
m_{11} < - 0
test1 <- function(x){
  TS <- sqrt(n)*mean(x)/sqrt(sigma2)
  testOutcome <- (TS > qnorm(1-alpha))
test2 <- function(x){
  TS <- sqrt(5)*mean(x[1:5])/sqrt(sigma2)
  testOutcome <- (TS > gnorm(1-alpha))
}
test3 <- function(x){
  TS \leftarrow sum(x^2/sigma2)
  testOutcome <- (TS > qchisq(1-2*alpha,n))
  if (mean(x) < 0) {testOutcome=0}</pre>
  testOutcome
```

```
testRejFreq <- function(mu){
  testRej <- matrix(0,5000,3)
  for (i in 1:5000){
    x <- rnorm(n,mean=mu,sd=sqrt(sigma2))
    testRej[i,1] <- test1(x)
    testRej[i,2] <- test2(x)
    testRej[i,3] <- test3(x)
}
  testRejF <- colMeans(testRej)
}
mu <- seq(-1,2.5,by=0.1)</pre>
```

table: rejection frequencies

n = 50					
	$\mu = 0$	$\mu = 0.1$	$\mu = 0.2$	$\mu = 0.5$	$\mu = 1$
test 1	0.0472	0.1706	0.4078	0.9702	1.0000
test 2	0.0444	0.0714	0.1168	0.3094	0.7284
test 3	0.0478	0.0840	0.1376	0.4570	0.9916
n = 500					
	$\mu = 0$	$\mu = 0.1$	$\mu = 0.2$	$\mu = 0.5$	$\mu = 1$
test 1	0.0534	0.7218	0.9986	1.0000	1.0000
test 2	0.0484	0.0800	0.1214	0.3060	0.6436
test 3	0.0500	0.1376	0.2576	0.9872	1.0000



#### Contents

- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis
- 2. finding and evaluating tests
- 2.1 likelihood ratio tes
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

# summary so far

• summary of results so far

$\mathbb{H}_{o}$	$\mathbb{H}_{1}$	UMP test?	example of R
$\mu = \mu_0$	$\mu = \mu_1$	Neyman-Person lemma	$\bar{x}_n < c$
$\mu = \mu_0$	$\mu > \mu_1$	(deferred)	
$\mu \leq \mu_0$	, , -	Karlin-Rubin theorem	$\bar{x}_n < c$
$\mu = \mu_0$	$\mu \neq \mu_0$	explore now	

#### **UMPU** tests

- if there is no UMP level  $\alpha$  test within the class of all tests, we might try to find a UMP level  $\alpha$  test within the class of unbiased tests.
- the next example shows that it is not trivial to find an UMP test within the class of  $\alpha$ -sized tests.
- example: let  $X_1, \ldots, X_n \sim N(\mu, \sigma^2)$  i.i.d. with  $\sigma^2$  known, and consider testing  $\mathbb{H}_0$ :  $\mu = \mu_0$  versus  $\mathbb{H}_1$ :  $\mu \neq \mu_0$ .
  - test 1: rejects  $\mathbb{H}_0$  if  $\bar{X}_n < \mu_0 rac{\sigma z_\alpha}{\sqrt{n}}$ . The power function is for the test with size  $\alpha$  is

$$\beta_{1}(\mu) = \mathbb{P}_{\mu} \left( \bar{X}_{n} < \mu_{0} - \frac{\sigma z_{\alpha}}{\sqrt{n}} \right) = \mathbb{P}_{\mu} \left( \bar{X}_{n} - \mu < \mu_{0} - \mu - \frac{\sigma z_{\alpha}}{\sqrt{n}} \right)$$

$$= \mathbb{P}_{\mu} \left( \frac{\bar{X}_{n} - \mu}{\sigma / \sqrt{n}} < -z_{\alpha} + \frac{\mu_{0} - \mu}{\sigma / \sqrt{n}} \right) = \mathbb{P} \left( Z > z_{\alpha} - \frac{\mu_{0} - \mu}{\sigma / \sqrt{n}} \right)$$

### **UMPU** tests

• example (cont'd): test 2: rejects  $\mathbb{H}_0$  if  $\bar{X}_n > \mu_0 + \frac{\sigma z_\alpha}{\sqrt{n}}$ 

$$\beta_2(\mu) = \mathbb{P}\left(Z > z_\alpha + \frac{\mu_0 - \mu}{\sigma/\sqrt{n}}\right)$$

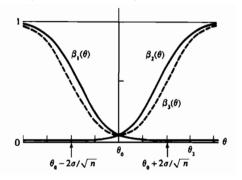
and take a point  $\mu_1 < \mu_0$ 

$$\beta_1(\mu_1) = \mathbb{P}\left(Z > z_{\alpha} - \frac{\mu_0 - \mu_1}{\sigma/\sqrt{n}}\right) > \mathbb{P}\left(Z > z_{\alpha} + \frac{\mu_0 - \mu_1}{\sigma/\sqrt{n}}\right) = \beta_2(\mu)$$

because  $\mu_0 - \mu_1 > 0$ . Now, if  $\mu_2 > \mu_0$ , we will have that  $\mu_0 - \mu_2 < 0$  and the inequality will reverse, that is,  $\beta_1(\mu_2) < \beta_2(\mu_2)$ .

#### **UMPU** tests

- the problem is that the class of tests is too wide: we may restrict the class of tests to search among  $\alpha$ -level unbiased tests.
- test 3: reject  $\mathbb{H}_0$  if  $\bar{X}_n > \theta_0 + \frac{\sigma z_{\alpha/2}}{\sqrt{n}}$  or  $\bar{X}_n > \theta_0 \frac{\sigma z_{\alpha/2}}{\sqrt{n}}$



- it happens that this test is the UMP test
- note that there is a loss of power compared to tests 1 and 2 at some parameter points

#### Contents

- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis
- 2. finding and evaluating tests
- 2.1 likelihood ratio tes
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

#### union-intersection tests

- in some situations, tests for complicated null hypotheses can be developed from tests for simpler null hypotheses
- suppose that the null hypothesis can be conveniently expressed as

$$\mathbb{H}_0 \colon oldsymbol{ heta} \in \bigcap_{\gamma \in \Gamma} \Theta_{\gamma}$$

and there are tests available for each testing problem  $\mathbb{H}_0^{(\gamma)}$ :  $\theta \in \Theta_0^{\gamma}$  versus  $\mathbb{H}_1^{(\gamma)}$ :  $\theta \in \Theta_1^{\gamma}$ , with rejection regions  $\{x: T_{\gamma}(x) \in R_{\gamma}\}$ 

- if any hypothesis  $\mathbb{H}_0^{(\gamma)}$  is rejected, then  $\mathbb{H}_0$  must also be rejected. Then the rejection region for the UI test is  $\bigcup_{\gamma \in \Gamma} \{x : T_{\gamma}(x) \in R_{\gamma}\}$
- in some situations, it is possible to simplify the expression for the rejection region of a union-intersection test

$$\bigcup_{\gamma \in \Gamma} \left\{ x : T_{\gamma}(x) \in R_{\gamma} \right\} = \left\{ x : \sup_{\gamma \in \Gamma} T_{\gamma}(x) > c \right\}$$

and hence 
$$T(x) = \sup_{\gamma \in \Gamma} T_{\gamma}(x)$$

### Gaussian union-intersection tests

- example: let  $X_1, \ldots, X_n \sim \text{iid } N(\mu, \sigma^2)$  and consider testing  $\mathbb{H}_0$ :  $\mu = \mu_0$  against  $\mathbb{H}_1$ :  $\mu \neq \mu_0$
- we may write the null hypothesis as the intersection of  $\mathbb{H}^L_0: \{\mu: \mu \leq \mu_0\}$  and  $\mathbb{H}^U_0: \{\mu: \mu \geq \mu_0\}$

LR tests 
$$\begin{cases} \text{reject } \mathbb{H}_0^L \colon \ \mu \leq \mu_0 \ \text{ if } \ \sqrt{n} \, \frac{\bar{X}_n - \mu_0}{\bar{S}_n} \geq t_L \\ \text{reject } \mathbb{H}_0^U \colon \ \mu \geq \mu_0 \ \text{ if } \ \sqrt{n} \, \frac{\bar{X}_n - \mu_0}{\bar{S}_n} \leq t_U \end{cases}$$

union-intersection test

reject 
$$\mathbb{H}_0$$
:  $\mu = \mu_0$  if  $t_L \leq \sqrt{n} \, \frac{\bar{X}_n - \mu_0}{S_n}$  or  $\sqrt{n} \, \frac{\bar{X}_n - \mu_0}{S_n} \leq t_U$ ,

which coincides with the two-sided LR t-test if  $t_L = -t_U \ge 0$  and then we can write

reject 
$$\mathbb{H}_0$$
:  $\mu = \mu_0$  if  $\sqrt{n} \frac{|X_n - \mu_0|}{S_n} \ge t_L$ 

which is also called the two-sided t-test

# union-intersection test and Neyman-Pearson lemma

• let  $X_1, \ldots, X_n \sim$  iid  $N(\mu, 1)$ . From the NP lemma, the  $\alpha$ -level uniformly most powerful test for  $\mathbb{H}_0: \mu = \mu_0$  against  $\mathbb{H}_1: \mu = \mu_1, \ \mu_1 < \mu_0$ , has rejection region

$$R = \left\{ x : \bar{x}_n < \mu_0 - \frac{\sigma z_\alpha}{\sqrt{n}} \right\}$$

• now consider testing  $\mathbb{H}_0: \mu = \mu_0$  against  $\mathbb{H}_1: \mu < \mu_0$ . We can write

$$\mathbb{H}_{\mathbf{0}}^{(\gamma)}$$
 :  $\mu = \mu_{\mathbf{0}}$ 
 $\mathbb{H}_{\mathbf{1}}^{(\gamma)}$  :  $\mu = \gamma$ 

with  $\gamma \in \Gamma = {\gamma : \gamma < \mu_0, \gamma \in \mathbb{R}}$ , which is a union-intersection test.

 notice that, for each of these tests, the rejection region R is unchanged. It follows that the rejection region for the UI test is

$$\bigcup_{\gamma \in \Gamma} \{ x : T_{\gamma}(x) \in R_{\gamma} \} = R$$

and also  $\sup_{\gamma \in \Gamma} T_{\gamma}(x) = T(x)$ .

• note that each of those tests are the UMP test individually.. it follows that rejection region R also constitutes the UMP for the composite hypothesis!

#### intersection-union tests

suppose that we may conveniently express the null as a union

$$\mathbb{H}_{\mathbf{0}} \colon \boldsymbol{\theta} \in \bigcup_{\gamma \in \Gamma} \Theta_{\gamma}$$

and there are tests available for each testing problem  $\mathbb{H}_0^{(\gamma)}$ :  $\theta \in \Theta_0^{\gamma}$  versus  $\mathbb{H}_1^{(\gamma)}$ :  $\theta \in \Theta_1^{\gamma}$ , with rejection regions  $\{x: T_{\gamma}(x) \in R_{\gamma}\}$ 

- if all hypotheses  $\mathbb{H}_0^{(\gamma)}$  is rejected, then  $\mathbb{H}_0$  must be rejected. The rejection region for the IU test is  $\bigcap_{\gamma \in \Gamma} \{x : T_{\gamma}(x) \in R_{\gamma}\}$
- in some situations, it is possible to simplify the expression for the rejection region of a intersection-union test

$$\bigcap_{\gamma \in \Gamma} \left\{ x : T_{\gamma}(x) \in R_{\gamma} \right\} = \left\{ x : \inf_{\gamma \in \Gamma} T_{\gamma}(x) \ge c \right\}$$

and hence  $T(x) = \inf_{\gamma \in \Gamma} T_{\gamma}(x)$ 

#### Contents

- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis

### 2. finding and evaluating tests

- 2.1 likelihood ratio tes
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests

### 2.5 p-values

- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

#### p-values

- so far, a statistical test would report only whether  $\mathbb{H}_0$  got accepted or rejected at a certain  $\alpha$ -level, but not by how much
- p-values are another way of conveying information about the outcome of the statistical test: what is the minimum  $\alpha$  such that  $\mathbb{H}_0$  is rejected?

$$\mathbb{H}_0$$
 rejected  $lpha=0.10$   $\mathbb{H}_0$  rejected at  $lpha=0.05$   $\mathbb{H}_0$  not rejected at  $lpha=0.01$ 

so lower values are indicative of "more convincing" rejections

• definition: the p-value is the smallest significance level such that x is in the rejection region

$$p(x) = \inf\{\alpha : x \in R_{\alpha}\}$$

where  $R_{\alpha}$  is the rejection region at significance level  $\alpha$ 

### p-values

example: take our well-known rejection region

$$R_{\alpha} = \left\{ x : \frac{\overline{x}_n - \mu_0}{\sigma / \sqrt{n}} > z_{\alpha} \right\}$$

for the test of  $\mathbb{H}_0$ :  $\mu \leq \mu_0$  against  $\mathbb{H}_1$ :  $\mu > \mu_0$ . Note that

$$\left\{x: \frac{\bar{x}_n - \mu_0}{\sigma/\sqrt{n}} > z_\alpha\right\} = \left\{x: \Phi\left(\frac{\bar{x}_n - \mu_0}{\sigma/\sqrt{n}}\right) > \alpha\right\}$$

for a given x, the p-value is the infimum  $\alpha$  such that  $\Phi\left(\frac{\bar{x}_n-\mu_0}{\sigma/\sqrt{n}}\right)>\alpha$  holds,

$$p = \Phi\left(\frac{\bar{x}_n - \mu_0}{\sigma/\sqrt{n}}\right)$$

#### Contents

- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis
- 2. finding and evaluating tests
- 2.1 likelihood ratio test
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

#### Contents

- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis
- 2. finding and evaluating tests
- 2.1 likelihood ratio tes
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

#### inference and set estimation

- we would like to make statements of the form  $\theta \in C(x)$ , where the set estimate  $C(x) \subset \Theta$  depends only on the realization of the sample
- if  $\theta$  is a scalar, C(x) will typically be an interval
- our goal is to build intervals in which the true parameter lies with a certain probability

$$\mathbb{P}\left(\mu=ar{X}_n
ight)=0$$
 point estimation  $\mathbb{P}\left(\mu\in C(x)
ight)\geq 0$  interval estimation

- definition: an interval estimate of a parameter  $\theta \in \Theta \subset \mathbb{R}$  is any pair of statistics L(x) and U(x) that satisfy  $L(x) \leq U(x)$  for all  $x \in S_X$ , whereas the random interval [L(X), U(X)] corresponds to the interval estimator
- it is possible that  $L(X) = -\infty$  or  $U(X) = \infty$
- · we will see soon that this topic is very much connected to hypothesis testing

### interval coverage

• example: if  $X_1, \ldots, X_4 \sim \text{iid } N(\mu, 1)$ ,  $[\bar{X}_4 - 1, \bar{X}_4 + 1]$  is a interval estimator of  $\mu$ . The probability that  $\mu \in C(x)$  is

$$\begin{split} & \mathbb{P}\big(\mu \in [\bar{X}_4 - 1, \bar{X}_4 + 1]\big) &= \mathbb{P}(\bar{X}_4 - 1 \le \mu \le \bar{X}_4 + 1) &= \mathbb{P}(|\bar{X}_4 - \mu| \le 1) \\ &= \mathbb{P}\left(\frac{|\bar{X}_4 - \mu|}{1/\sqrt{4}} \le \frac{1}{1/\sqrt{4}}\right) &= \mathbb{P}(|Z| \le 2) &= 0.9544 \end{split}$$

- definition: the probability that the interval estimator [L(X), U(X)] of  $\theta$  includes the true parameter value  $\theta$  is the coverage probability
- definition: the confidence coefficient of [L(X), U(X)] is the infimum of the coverage probabilities, namely,  $\inf_{\theta \in \Theta} \mathbb{P}_{\theta}(\theta \in [L(X), U(X)])$
- ullet since heta is unknown, the best we can offer is the infimum coverage probability, that is to say, the confidence coefficient
- keep in mind that the random quantity is the interval L(X) and U(X), but not  $\theta$ , which is unknown but a fixed quantity
  - in the example above, the bounds depended on  $\bar{X}_n$ , which is a random quantity

### scale uniform interval estimator

• example: let  $X_1, \ldots, X_n \sim \text{iid } U(0, \theta)$  and consider  $[aX_{(n)}, bX_{(n)}]$  with  $1 \leq a < b$ . The coverage probability is

$$\mathbb{P}_{\theta}\left(aX_{(n)} \leq \theta \leq bX_{(n)}\right) = \mathbb{P}\left(\theta/b \leq X_{(n)} \leq \theta/a\right)$$

and cdf of  $X_{(n)}$  is

$$\mathbb{P}\left(X_{(n)} \leq k\right) = \prod_{i=1}^{n} \mathbb{P}\left(X_{i} \leq k\right) = \prod_{i=1}^{n} \int_{0}^{k} \frac{1}{\theta} dx$$
$$= \prod_{i=1}^{n} \frac{k}{\theta} = \left[\frac{k}{\theta}\right]^{n}$$
$$\mathbb{P}\left(\theta/b \leq X_{(n)} \leq \theta/a\right) = \left[\frac{\theta/a}{\theta}\right]^{n} - \left[\frac{\theta/b}{\theta}\right]^{n} = a^{-n} - b^{-n}$$

### scale uniform interval estimator

• example: (cont'd) consider alternatively  $[X_{(n)} + c, X_{(n)} + d]$ 

$$\mathbb{P}_{\theta}(X_{(n)} + c \leq \theta \leq X_{(n)} + d) = \mathbb{P}_{\theta} \left(\theta - d \leq X_{(n)} \leq \theta - c\right)$$
$$= \left[\frac{\theta - c}{\theta}\right]^{n} - \left[\frac{\theta - d}{\theta}\right]^{n}$$
$$= \left(1 - c/\theta\right)^{n} - \left(1 - d/\theta\right)^{n}$$

which depends on  $\theta$ , with confidence coefficient zero  $(\theta \to \infty)$ 

# interval estimator for a Gaussian sample mean

• example: if  $X_1, \ldots, X_n \sim$  iid  $N(\mu, \sigma^2)$ ,  $\sigma^2$  known. Consider testing  $\mathbb{H}_0 : \mu = \mu_0$  against  $\mathbb{H}_1 : \mu \neq \mu_0$ . We would then typically use the rejection region

$$R = \left\{ X : |\bar{X}_n - \mu_0| > z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

since test has size  $\alpha$ ,  $\mathbb{P}(x \in R^c | \mu = \mu_0) = 1 - \alpha$ . But

$$R^{c} = \left\{ X : |\bar{X}_{n} - \mu_{0}| < z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\} = \left\{ X : -z_{\alpha/2} \frac{\sigma}{\sqrt{n}} < \bar{X}_{n} - \mu_{0} < z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

$$= \left\{ X : -\bar{X}_{n} - z_{\alpha/2} \frac{\sigma}{\sqrt{n}} < -\mu_{0} < -\bar{X}_{n} + z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

$$= \left\{ X : \bar{X}_{n} - z_{\alpha/2} \frac{\sigma}{\sqrt{n}} < \mu_{0} < \bar{X}_{n} + z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

i.e., there is a probability  $1-\alpha$  that  $\mu_0$  is in the interval above.

# interval estimator for a Gaussian sample mean

- there is a clear correspondence between confidence sets and tests
  - the acceptance region is a set in the sample space such that  $\mathbb{H}_0$ :  $\mu=\mu_0$  is not rejected. It is a function of  $\mu_0$ , but not data

$$A(\mu_0) = \left\{ \mathbf{x} : \mu_0 - z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \le \bar{\mathbf{x}}_n \le \mu_0 + z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

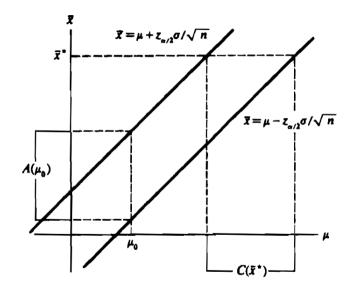
 the confidence interval is set with plausible values of the parameters. It is a function of data, but not parameters

$$C(\mathbf{x}) = \left\{ \mu : \bar{\mathbf{x}}_n - \mathbf{z}_{\alpha/2} \frac{\sigma}{\sqrt{n}} \le \mu \le \bar{\mathbf{x}}_n + \mathbf{z}_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

therefore

$$x \in A(\mu_0) \iff \mu_0 \in C(x)$$

# interval estimator for a Gaussian sample mean



# rejection regions and confidence intervals

- this notion can be made formal
- theorem (CB 9.2.2): for each  $\theta_0 \in \Theta$ , let  $A(\theta_0)$  be the acceptance region of level  $\alpha$  of  $\mathbb{H}_0 : \theta = \theta_0$ . For each  $\mathbf{x} \in \mathcal{X}$ , define

$$C(x) = \{\theta_0 : x \in A(\theta_0)\}\$$

then the random set C(X) is a  $1-\alpha$  confidence set. Conversely, let C(X) be a  $1-\alpha$  confidence set. Define

$$A(\theta_0) = \{x : \theta_0 \in C(x)\}$$

then  $A(\theta_0)$  is the acceptance region of a level- $\alpha$  test with  $\mathbb{H}_0: \theta = \theta_0$ .

# rejection regions and confidence intervals

• proof:  $A(\theta_0)$  is acceptance region of a level- $\alpha$  test so  $\mathbb{P}_{\theta_0}(X \notin A(\theta_0)) \leq \alpha$  and  $\mathbb{P}_{\theta_0}(X \in A(\theta_0)) \geq 1 - \alpha$ . Then

$$\mathbb{P}_{\theta}(\theta \in C(X)) = \mathbb{P}_{\theta}(X \in A(\theta)) \geq 1 - \alpha$$

so C(X) is a  $1-\alpha$  confidence set.

ullet the type-I error probability for  $\mathbb{H}_0$  :  $heta= heta_0$  with acceptance region  $A( heta_0)$  is

$$\mathbb{P}_{\theta_0}(\mathbf{X} \notin A(\theta_0)) = \mathbb{P}_{\theta_0}(\theta_0 \notin C(\mathbf{X})) \leq \alpha$$

so this is a  $\alpha$ -level test.

#### Contents

- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis
- 2. finding and evaluating tests
- 2.1 likelihood ratio tes
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercise:

- two relevant quantities:
  - size of the interval: length or volume
  - coverage probability: probability that true parameter is in the set
- the latter is generally a function of the parameter, so we usually take the infimum over the parameter space.
  - this is the confidence coefficient
- we will soon see that performances of tests and set estimates are closely connected

- question: we can optimize the length of an interval while keeping coverage probability constant at  $1-\alpha$ ?
- example: take  $X_1, \ldots, X_n$  iid  $N(\mu, \sigma^2)$ ,  $\sigma$  known. Then

$$\mathbb{P}\left(a \leq \frac{\bar{X}_n - \mu}{\sigma/\sqrt{n}} \leq b\right) = \mathbb{P}\left(a \leq Z \leq b\right) = 1 - \alpha$$

gives the confidence interval

$$\left\{\mu: \bar{\mathbf{x}}_n - b\frac{\sigma}{\sqrt{n}} \le \mu \le \bar{\mathbf{x}}_n - a\frac{\sigma}{\sqrt{n}}\right\}$$

- what choice of a and b minimizes length while keeping  $1-\alpha$  coverage?
  - minimize b a with  $\mathbb{P}(a \le Z \le b) = 1 \alpha$

а	Ь	P(Z < a)	P(Z > b)	b — а
-1.34	2.33	.09	.01	3.67
-1.44	1.96	.075	.025	3.40
-1.65	1.65	.05	.05	3.30

- table suggests that a = -b = 1.65 is the optimum
- it is not a requirement that the interval should symmetric: this is a consequence of the symmetry of the normal distribution

- theorem (CB 9.3.2): let f(x) be a unimodal pdf. If an interval [a, b] satisfies
  - (i)  $\int_{a}^{b} f(x) dx = 1 \alpha$
  - (ii) f(a) = f(b) > 0
  - (iii)  $a \le x^* \le b$ , where  $x^*$  is the mode of f(x)

then [a,b] is the shortest interval among all intervals such that  $\int_a^b f(x)dx = 1 - \alpha$ .



### optimality

- since there is a correspondence between confidence sets and hypothesis tests, there must be some correspondence between their optimalities
- consider a situation where  $X \sim f(x|\theta)$  and construct a confidence set  $C(\theta)$  for  $\theta$  by inverting an acceptance region  $A(\theta)$
- definition: the probability of true coverage is  $\mathbb{P}_{\theta}(\theta \in C(X))$
- definition: the probability of false coverage is the probability that  $\theta'$  is covered when  $\theta$  is the true parameter

$$\mathbb{P}_{\theta}(\theta' \in C(X))$$
 if  $\theta' \neq \theta$ 

• definition: the  $1-\alpha$  confidence set that minimizes the probability of false coverage is called the uniformly most accurate confidence set (UMA)

### optimality

• theorem (CB 9.3.5): let  $X \sim f(x|\theta)$  where  $\theta$  is real-valued. For each  $\theta_0 \in \Theta$ , let  $A^*(\theta_0)$  be the UMP level- $\alpha$  acceptance region of a test of  $\mathbb{H}_0: \theta = \theta_0$  versus  $\mathbb{H}_1: \theta > \theta_0$ . Let  $C^*(x)$  be the  $1-\alpha$  confidence set formed by inverting the UMP acceptance regions. Then, for any other confidence region  $C^*(X)$ ,

$$\mathbb{P}_{\theta}(\theta' \in C^*(X)) \leq \mathbb{P}_{\theta}(\theta' \in C(X))$$

that is,  $C^*(X)$  is a UMA lower confidence bound.

• proof: let  $\theta' < \theta$ . Then

$$\begin{array}{ccc} \mathbb{P}_{\theta} \left( \theta' \in C^*(\boldsymbol{X}) \right) & = & \mathbb{P}_{\theta} \left( \boldsymbol{X} \in A^*(\theta') \right) \\ \leq & \mathbb{P}_{\theta} \left( \boldsymbol{X} \in A(\theta') \right) & = & \mathbb{P}_{\theta} \left( \theta' \in C(\boldsymbol{X}) \right) \end{array}$$

80 / 81

#### Contents

- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis
- 2. finding and evaluating tests
- 2.1 likelihood ratio tes
- 2.2 most powerful tests
- 2.3 restricting the class of UMP test
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

### Reference:

• Casella and Berger, Ch. 8 and 9

## Exercises:

- 8.1-8.3, 8.5-8.8, 8.12-8.19, 8.22(a), 8.27, 8.28, 8.32, 8.37, 8.51
- 9.1-9.14, 9.16-9.17, 9.23, 9.34-9.42, 9.47-9.52

• proof: let [a', b'] be any interval with b' - a' < b - a. There are two cases:  $b' \le a$  and b' > a. If  $b' \le a$ , then  $a' \le b' \le a \le x^*$  and

$$\int_{a'}^{b'} f(x) dx \leq f(b')(b'-a')$$

since  $x \le b' \le x^* \Rightarrow f(x) \le f(b')$ . Now,

$$f(b')(b'-a') \leq f(a)(b'-a')$$

since f(x) is nondecreasing for  $b' \le a \le x^*$  and

$$f(a)(b'-a') < f(a)(b-a) \le \int_a^b f(x)dx = 1-\alpha$$

since, using (ii) and (iii),  $f(x) \ge f(a)$  for  $a \le x \le b$ . So [a', b'] cannot have the same coverage probability. Complete argument for  $b' \le a$  case.



1/1